

## Description

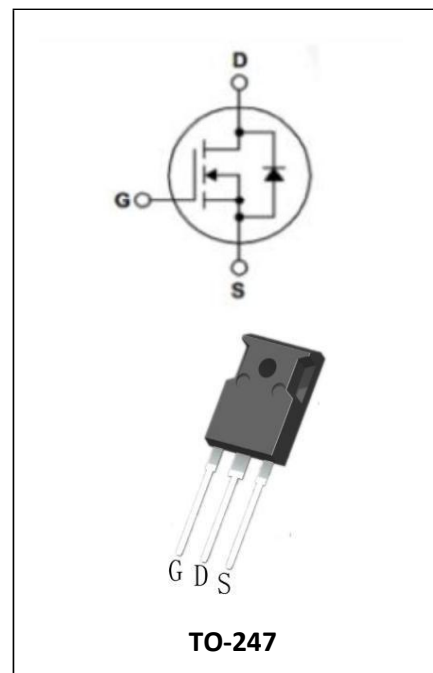
MD100N20 the silicon N-channel Enhanced MOSFETs, is obtained by advanced MOSFET technology which reduce the conduction loss, improve switching performance and enhance the avalanche energy. The transistor is suitable device for SMPS, High speed switching and general purpose application

## General Features

- ①  $V_{DS}=200V, I_D=100A$   $R_{DS(ON)} < 28m\Omega @ V_{GS}=10V$
- ② Fast Switching
- ③ Low  $C_{rss}$
- ④ 100% avalanche tested
- ⑤ Improved  $dv/dt$  capability
- ⑥ RoHS product

## Application

- ① High frequency switching mode power supply



## Package Marking And Ordering Information:

Ordering Codes	Package	Product Code	Packing
MD100N20	TO-247	MD100N20	Tube

## Absolute Maximum Ratings @ $T_a=25^\circ\text{C}$ (unless otherwise specified)

Symbol	Parameter	Rating	Units
$V_{DSS}$	Drain-to-Source Voltage	200	V
$I_D$	Continuous Drain Current	100	A
	Continuous Drain Current $T_c = 100^\circ\text{C}$	50	A
$I_{DM}$	Pulsed Drain Current(Note1)	320	A
$V_{GS}$	Gate-to-Source Voltage	$\pm 30$	V
$E_{AS}$	Single Pulse Avalanche Energy(Note2)	2600	mJ
$dv/dt$	Peak Diode Recovery $dv/dt$ (Note3)	5.0	V/ns
$P_D$	Power Dissipation TO-3PN\TO-247	390	W
	Derating Factor above $25^\circ\text{C}$	3.13	W/ $^\circ\text{C}$
$T_J, T_{stg}$	Operating Junction and Storage Temperature Range	150, $-55$ to $150$	$^\circ\text{C}$

$T_L$	Maximum Temperature for Soldering	300	$^{\circ}\text{C}$
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### Thermal characteristics

#### Thermal characteristics (No FullPAK) TO-247

Symbol	Parameter	RATINGS	Units
$R_{\theta JC}$	Junction-to-Case	0.32	$^{\circ}\text{C}/\text{W}$
$R_{\theta JA}$	Junction-to-Ambient	40	$^{\circ}\text{C}/\text{W}$

### Electrical Characteristics at $T_C = 25^{\circ}\text{C}$ , unless otherwise specified

OFF Characteristics						
Symbol	Parameter	Test Conditions	Values			Units
			Min.	Typ.	Max.	
$V_{DSS}$	Drain to Source Breakdown Voltage	$V_{GS}=0\text{V}$ , $I_D=250\mu\text{A}$	200	--	--	V
$\Delta BV_{DSS}/\Delta T_J$	$B_{vdss}$ Temperature Coefficient	$I_D=250\mu\text{A}$ , Reference 25	--	0.25	--	$\text{V}/^{\circ}\text{C}$
$I_{DSS}$	Drain to Source Leakage Current	$V_{DS}=200\text{V}$ , $V_{GS}=0\text{V}$ , $T_j=25^{\circ}\text{C}$	--	--	1	$\mu\text{A}$
		$V_{DS}=160\text{V}$ , $V_{GS}=0\text{V}$ , $T_j=125^{\circ}\text{C}$	--	--	10	$\mu\text{A}$
$I_{GSS(F)}$	Gate to Source Forward Leakage	$V_{GS}=+30\text{V}$	--	--	100	nA
$I_{GSS(R)}$	Gate to Source Reverse Leakage	$V_{GS}=-30\text{V}$	--	--	100	nA

ON Characteristics						
Symbol	Parameter	Test Conditions	Values			Units
			Min.	Typ.	Max.	
$R_{DS(ON)}$	Drain-to-Source On- Resistance	$V_{GS}=10\text{V}$ , $I_D=40\text{A}(\text{Note4})$	--	23	28	$\text{m}\Omega$
$V_{GS(TH)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$ , $I_D=250\mu\text{A}(\text{Note4})$	2.0	--	4.0	V
$g_{fs}$	Forward Transconductance	$V_{DS}=15\text{V}$ , $I_D=40\text{A}(\text{Note4})$	--	50	--	S



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MD100N20

Dynamic Characteristics						
Symbol	Parameter	Test Conditions	Values			Units
			Min.	Typ.	Max.	
$R_g$	Gate resistance	$f = 1.0\text{MHz}$	--	0.95	--	$\Omega$
$C_{iss}$	Input Capacitance	$V_{GS}=0V$ $V_{DS}=25V$ $f=1.0\text{MHz}$	--	9650	--	PF
$C_{oss}$	Output Capacitance		--	968	--	
$C_{rss}$	Reverse Transfer Capacitance		--	57	--	

Switching Characteristics						
Symbol	Parameter	Test Conditions	Values			Units
			Min.	Typ.	Max.	
$t_{d(ON)}$	Turn-on Delay Time	$I_D = 100A$ $V_{DD} = 100V$ $V_{GS} = 10V$ $R_G = 20\Omega$	--	60	--	ns
$t_r$	Rise Time		--	250	--	
$t_{d(OFF)}$	Turn-Off Delay Time		--	92	--	
$t_f$	Fall Time		--	118	--	
$Q_g$	Total Gate Charge	$I_D = 100A$ $V_{DD} = 160V$ $V_{GS} = 10V$	--	152	--	nC
$Q_{gs}$	Gate to Source Charge		--	56	--	
$Q_{gd}$	Gate to Drain ("Miller") Charge		--	39.5	--	

Source-Drain Diode Characteristics						
Symbol	Parameter	Test Conditions	Values			Units
			Min.	Typ.	Max.	
$I_S$	Continuous Source Current (Body Diode)	$TC=25^\circ C$	--	--	100	A
$I_{SM}$	Maximum Pulsed Current (Body Diode)		--	--	320	A
$V_{SD}$	Diode Forward Voltage	$I_S=100A,$ $V_{GS}=0V(\text{Note4})$	--	--	1.2	V
$T_{rr}$	Reverse Recovery Time	$I_S=100A,$ $T_j = 25^\circ C$ $dI_F/dt=100A/us,$ $V_{GS}=0V$	--	192	--	ns
$Q_{rr}$	Reverse Recovery Charge		--	1853	--	nC
$I_{rrm}$	Reverse Recovery Current		--	19.3	--	A

Note1: Pulse width limited by maximum junction temperature

Note2:  $L=20\text{mH}$ ,  $V_{DS}=50V$ , Start  $T_J=25^\circ C$

Note3:  $I_{SD} = 100A, di/dt \leq 100A/us, V_{DD} \leq BV_{DS}$ , Start  $T_J=25$

Note4: Pulse width  $t_p \leq 300\mu s$ ,  $\delta \leq 2\%$



### Characteristics Curves

Figure 1a Safe Operating Area

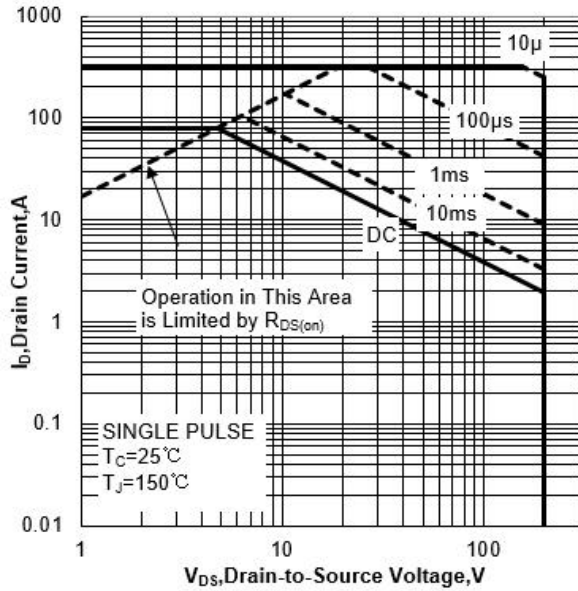


Figure 2 Power Dissipation

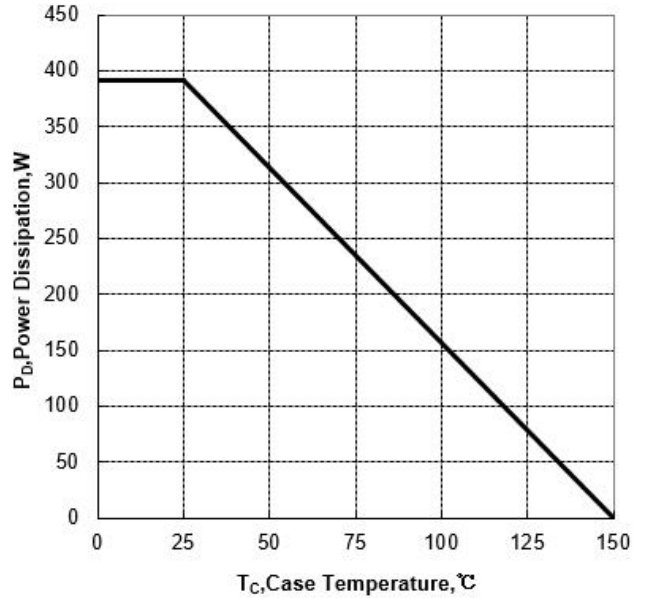


Figure 3 Max Thermal Impedance

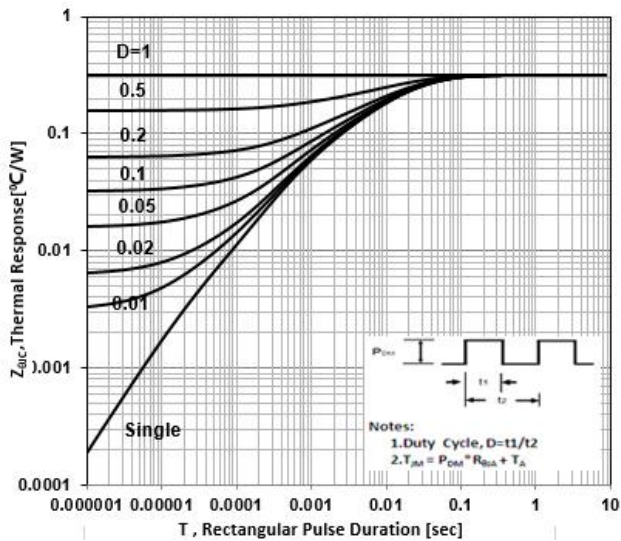


Figure 4 Typical Output Characteristics

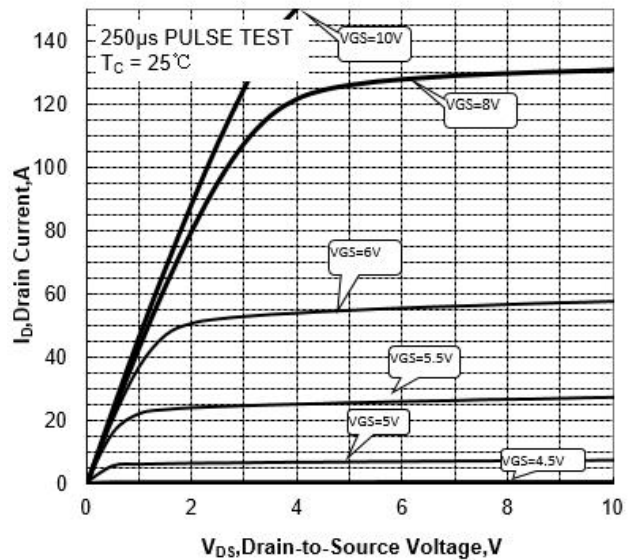


Figure 5 Typical Transfer Characteristics

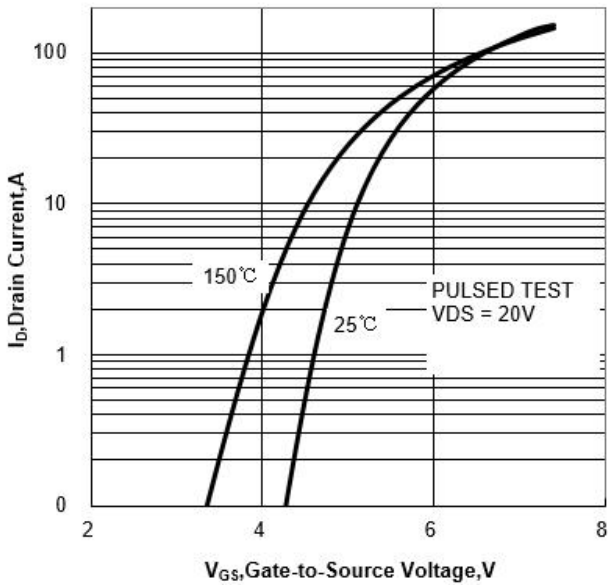


Figure 6 Typical Drain to Source ON Resistance vs Drain Current

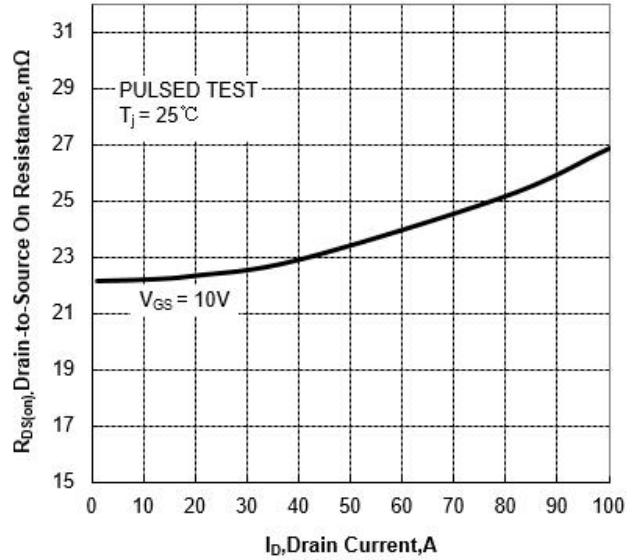


Figure 7 Typical Drain to Source on Resistance vs Junction Temperature

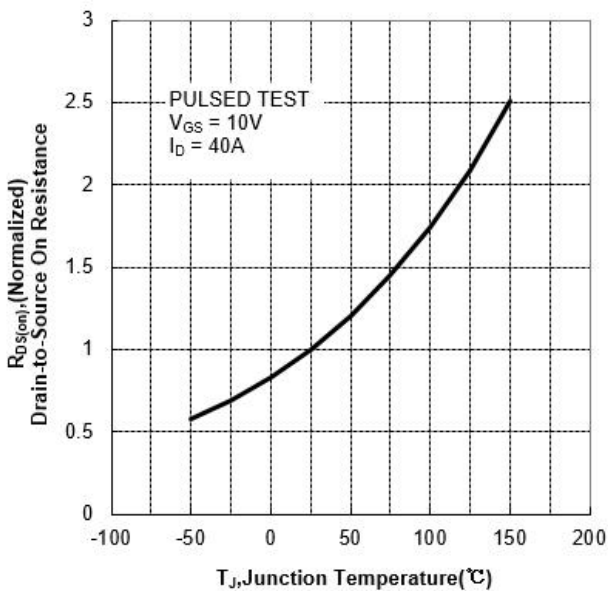


Figure 8 Typical Theshold Voltage vs Junction Temperature

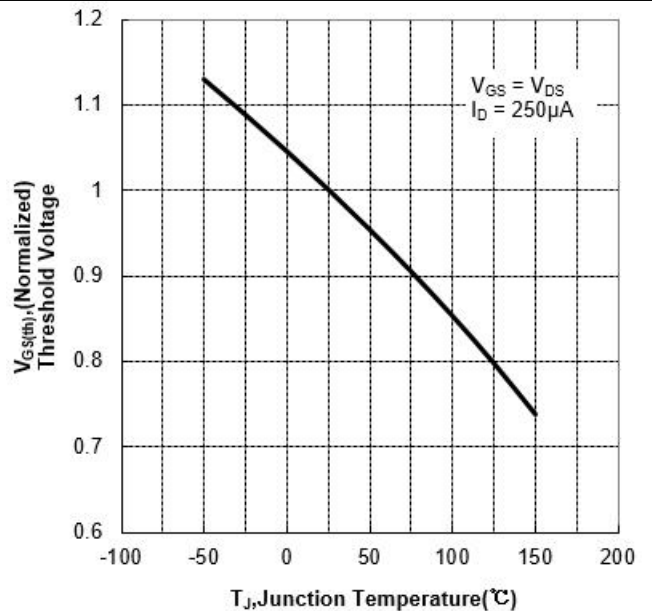


Figure 9 Typical Breakdown Voltage vs Junction Temperature

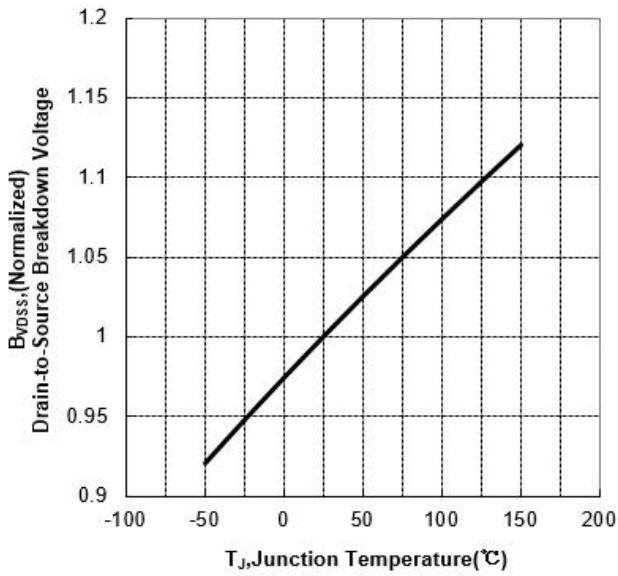


Figure 10 Typical Capacitance vs Drain to Source Voltage

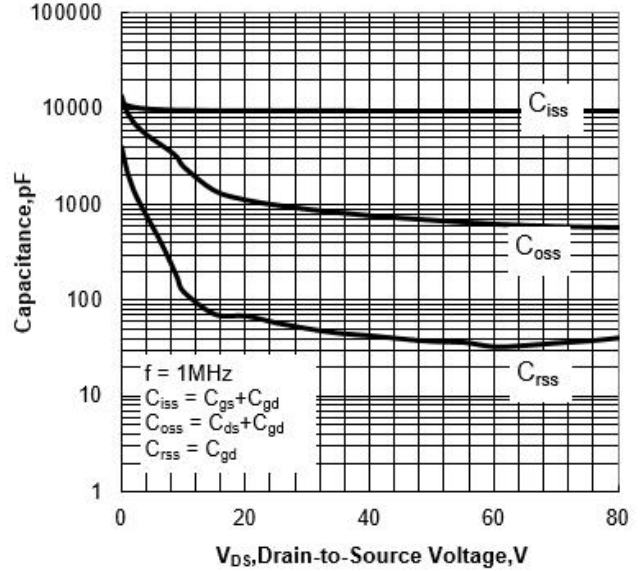
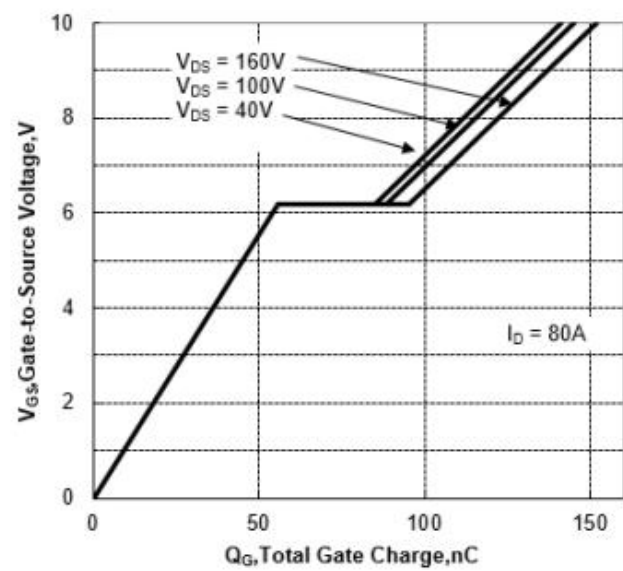


Figure 11 Typical Gate Charge vs Gate to Source Voltage



Test Circuit and Waveform

Figure 12 Gate Charge Test Circuit

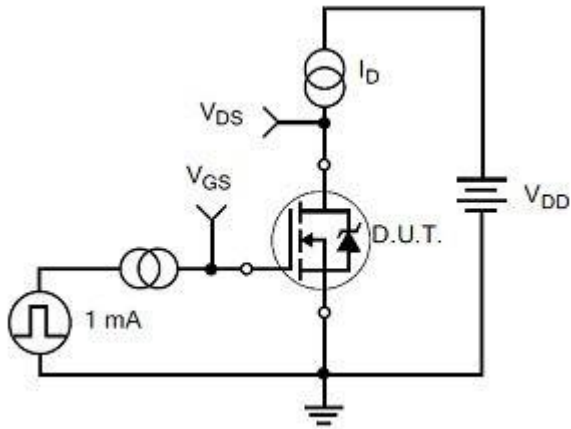


Figure 13 Gate Charge Waveforms

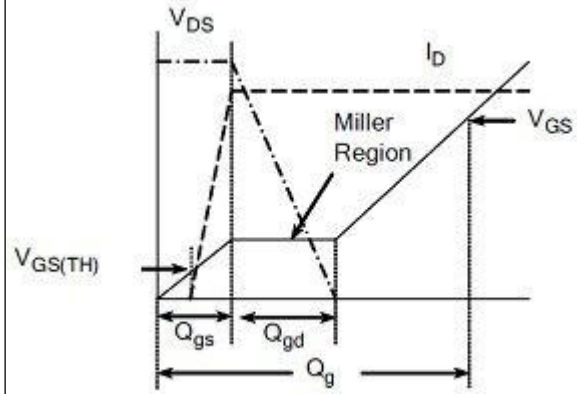


Figure 14 Resistive Switching Test Circuit

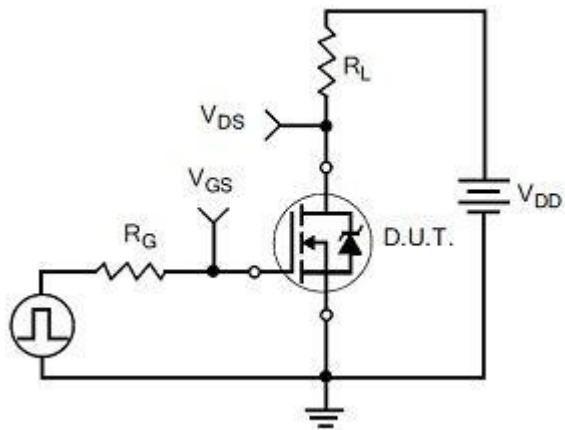


Figure 15 Resistive Switching Waveforms

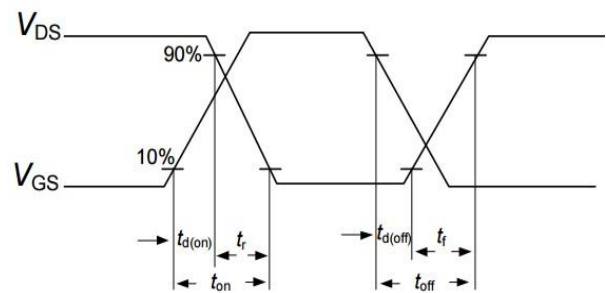


Figure 16 Diode Reverse Recovery Test Circuit

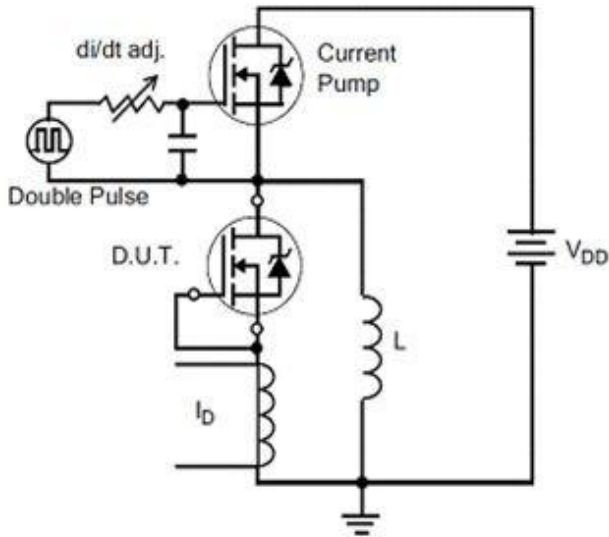


Figure 17 Diode Reverse Recovery Waveform

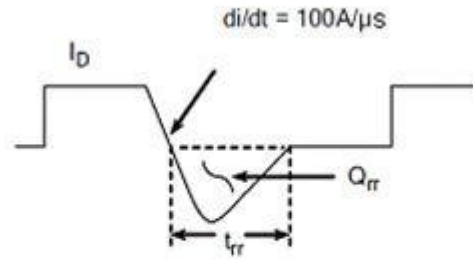


Figure 18 Unclamped Inductive Switching Test Circuit

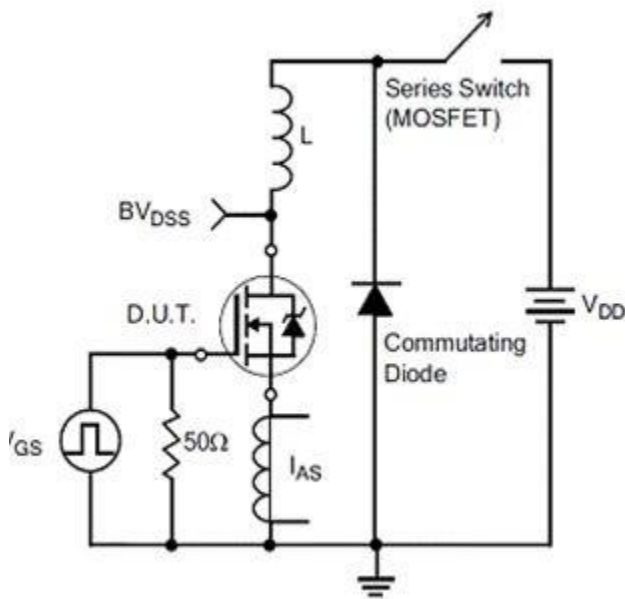
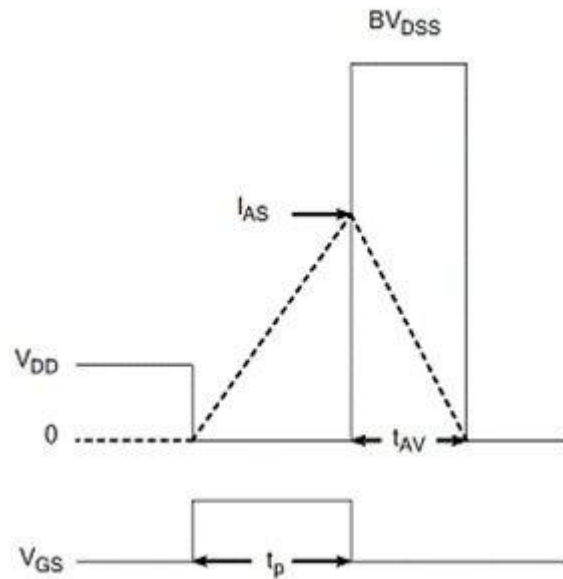
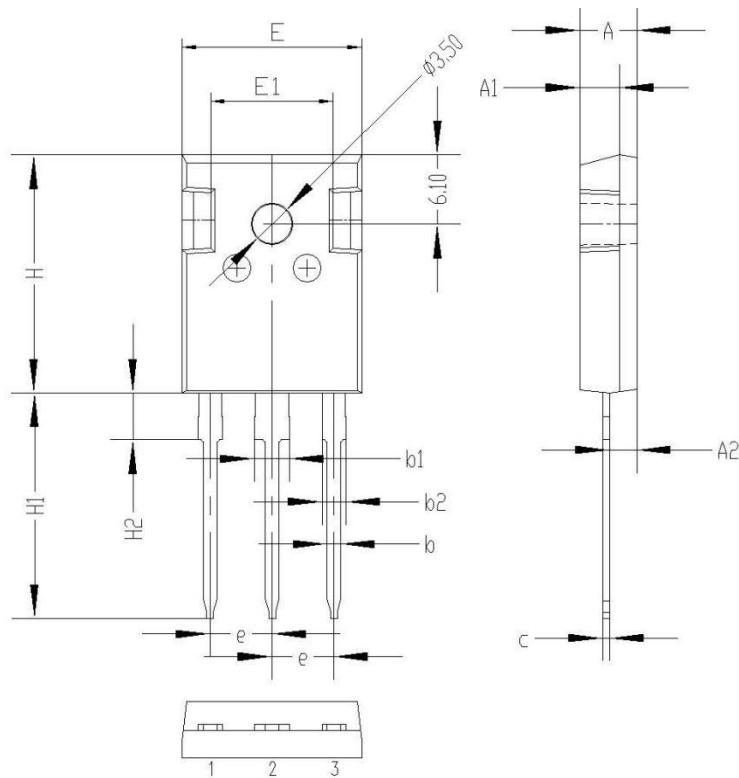


Figure 19 Unclamped Inductive Switching Waveform





Package Description



Symbol	Unit mm		
	Min	Typ	Max
A	4.8	5.00	5.20
A1	3.3	3.5	3.7
A2	2.20	2.40	2.60
b	1.00	1.2	1.40
b1	2.90	3.10	3.30
b2	1.80	2.00	2.20
c	0.50	0.60	0.70
e	5.25	5.45	5.65
E	15.2	15.7	16.2
H	20.8	21	21.2
H1	19.5	20.0	20.5
H2	3.9	4.1	4.3
G	5.9	6.1	6.3
$\Phi P$	3.30	3.50	3.70

TO-247 Package



**NOTE:**

1. Exceeding the maximum ratings of the device in performance may cause damage to the device, even the permanent failure, which may affect the dependability of the machine. Please do not exceed the absolute maximum ratings of the device when circuit designing.
2. When installing the heat sink, please pay attention to the torsional moment and the smoothness of the heat sink.
3. MOSFETs is the device which is sensitive to the static electricity, it is necessary to protect the device from being damaged by the static electricity when using it.
4. Shenzhen Minos reserves the right to make changes in this specification sheet and is subject to change without prior notice.

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